DATA SHEET



# MOS FIELD EFFECT TRANSISTOR μ**ΡΑ1874**

## N-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

### DESCRIPTION

The  $\mu$ PA1874 is a switching device which can be driven directly by a 2.5-V power source.

This device features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power switch of portable machine and so on.

### **FEATURES**

- 2.5-V drive available
- · Low on-state resistance
- $R_{DS(on)1} = 14.0 \text{ m}\Omega \text{ MAX.} (V_{GS} = 4.5 \text{ V}, I_D = 4.0 \text{ A})$  $R_{DS(on)2} = 14.5 \text{ m}\Omega \text{ MAX.}$  (VGS = 4.0 V, ID = 4.0 A)  $R_{DS(on)3}$  = 16.5 m $\Omega$  MAX. (V<sub>GS</sub> = 3.1 V, I<sub>D</sub> = 4.0 A)  $R_{DS(on)4} = 19.5 \text{ m}\Omega \text{ MAX.}$  (VGS = 2.5 V, ID = 4.0 A)
- Built-in G-S protection diode against ESD

### **ORDERING INFORMATION**

PART NUMBER	PACKAGE
$\mu$ PA1874GR-9JG	Power TSSOP8

### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^{\circ}C$ )

Drain to Source Voltage ( $V_{GS} = 0 V$ )	VDSS	30	V
Gate to Source Voltage ( $V_{DS} = 0 V$ )	Vgss	±12	V
Drain Current (DC) (T <sub>A</sub> = 25°C)	ID(DC)	±8.0	А
Drain Current (pulse) <sup>Note 1</sup>	D(pulse)	±80	А
Total Power Dissipation (2 unit) Note 2	P⊤	2.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	–55 to +150	°C

### **Notes 1.** PW $\leq$ 10 $\mu$ s, Duty Cycle $\leq$ 1%

- 2. Mounted on ceramic substrate of 5000 mm<sup>2</sup> x 1.1 mm
- Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

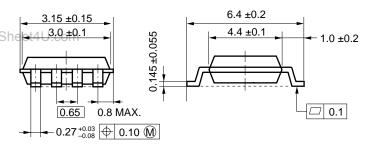
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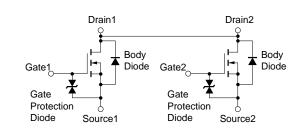
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<u>Ă</u>ĦĦ<u>Ă</u> :Drain1 1 1.2 MAX. 2, 3 :Source1 - 1.0±0.05 4 :Gate1 5 :Gate2 0.25 6, 7 :Source2 :Drain2 8 3° +5° 0.5 E 0.1±0.05 F E 0.6 +0.15

PACKAGE DRAWING (Unit: mm)



### EQUIVALENT CIRCUIT

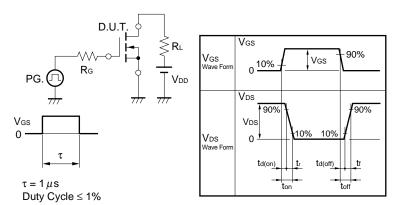


### ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25°C)

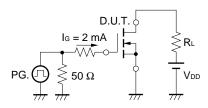
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	DSS	Vds = 30 V, Vgs = 0 V			10	μA
Gate Leakage Current	lgss	V <sub>GS</sub> = ±12 V, V <sub>DS</sub> = 0 V			±10	μA
Gate Cut-off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1.0 mA	0.5	1.0	1.5	V
Forward Transfer Admittance	<b>y</b> fs	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 4.0 A	5.0			S
Drain to Source On-state Resistance	RDS(on)1	$V_{GS} = 4.5 V$ , $I_{D} = 4.0 A$	9.0	11.0	14.0	mΩ
	RDS(on)2	V <sub>GS</sub> = 4.0 V, I <sub>D</sub> = 4.0 A	9.5	11.5	14.5	mΩ
	RDS(on)3	V <sub>GS</sub> = 3.1 V, I <sub>D</sub> = 4.0 A	10.0	12.5	16.5	mΩ
	RDS(on)4	V <sub>GS</sub> = 2.5 V, I <sub>D</sub> = 4.0 A	11.0	14.5	19.5	mΩ
Input Capacitance	Ciss	V <sub>DS</sub> = 10 V		1280		pF
Output Capacitance	Coss	V <sub>GS</sub> = 0 V		260		pF
Reverse Transfer Capacitance	Crss	f = 1.0 MHz		170		pF
Turn-on Delay Time	td(on)	V <sub>DD</sub> = 10 V, I <sub>D</sub> = 4.0 A		70		ns
Rise Time	tr	V <sub>GS</sub> = 4.0 V		310		ns
Turn-off Delay Time	td(off)	R <sub>G</sub> = 10 Ω		440		ns
Fall Time	tr			410		ns
Total Gate Charge	QG	V <sub>DD</sub> = 24 V		14		nC
Gate to Source Charge	QGS	V <sub>GS</sub> = 4.0 V		2.0		nC
Gate to Drain Charge	Qgd	ID = 8.0 A		7.0		nC
Diode Forward Voltage	VF(S-D)	DataSheet4U.com I⊧ = 8.0 A, V₀s = 0 V		0.81		V
Reverse Recovery Time	trr	IF = 8.0 A, VGS = 0 V		290		ns
Reverse Recovery Charge	Qrr	di/dt = 50 A/ μs		310		nC

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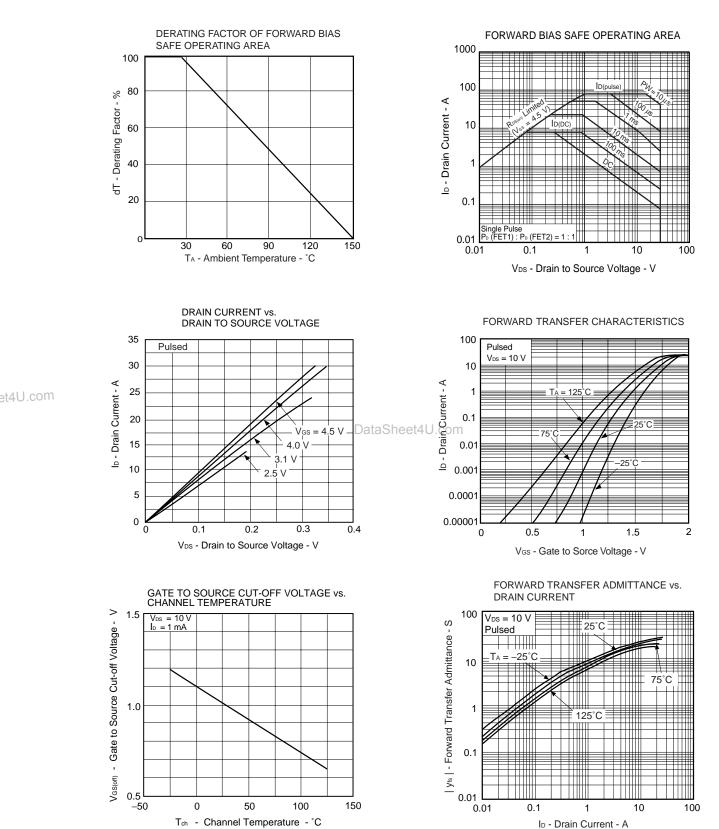
### TEST CIRCUIT 1 SWITCHING TIME



### **TEST CIRCUIT 2 GATE CHARGE**

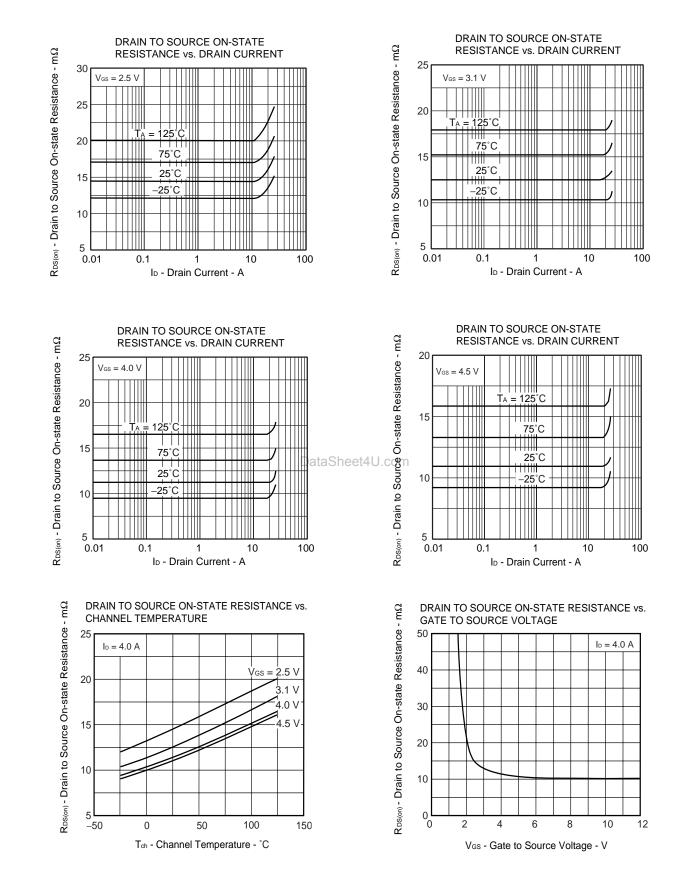


### TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25°C)



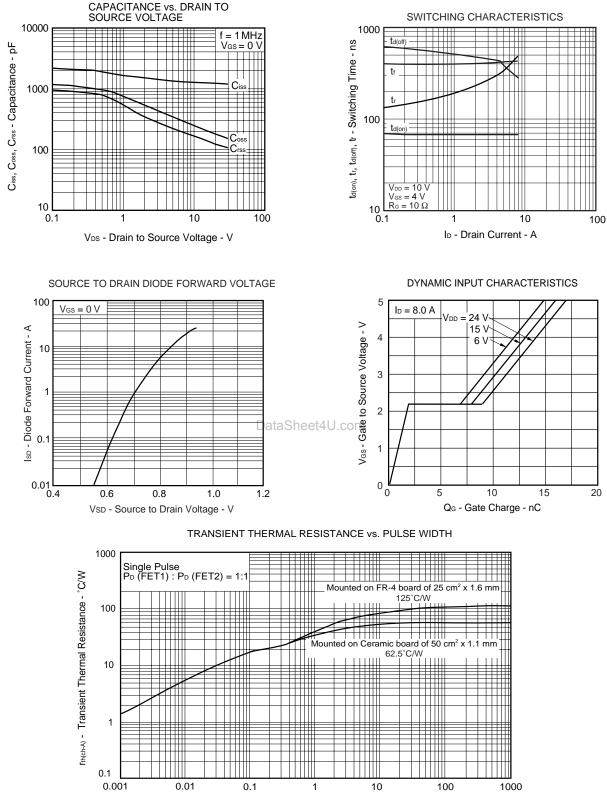
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PW - Pulse Width - s

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